Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/627,550	ZHANG, CHI	
Examiner	Art Unit	
Duc Truong	1711	

SEARCHED				
Class	Subclass	Date	Examiner	
427	487	2/3/2005	DT	
428	690			
428	917			
528	422			
528	373			
528	391			
525	328.5			
525	329.4			
525	540			
525	535			
had	ste	10/14/2005	DT	

INTERFERENCE SEARCHED					
Class	Subclass	Date		Examiner	
427	487	10/14/2005		DT	
528	422				
525	328.5				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
sSTN	2/3/2005	DT		
Inventor name search	r	<b>C</b> I		